



CE EMC TEST REPORT

for

Product: Switch on the power supply control module Model:RSRMEV2300-SC

Report No.:PTC23071200201E-EM01

Issued for

Shenzhen Lampow Electronics co., Ltd

11th A building Quanju industrial park jiangshi road ,gongming shenzhen
china

Issued by

Precise Testing & Certification (Guangdong) Co., Ltd.

Building 1, No. 6, Tongxin Road, Dongcheng Street, Dongguan, Guangdong,

China.

TEL: +86-769-3880 8222 FAX: +86-769-3882 6111

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1. TEST CERTIFICATION

Product: Switch on the power supply control module

Model: RSRMEV2300-SC

Applicant: Shenzhen Lampow Electronics co., Ltd

Address: 11th A building Quanju industrial park jiangshi road ,gongming shenzhen

china

Manufacturer: Shenzhen Lampow Electronics co., Ltd

Address: 11th A building Quanju industrial park jiangshi road ,gongming shenzhen

china

Test Date: July 7,2023 ~ August 11, 2023

Issued Date: August 11, 2023

Test Voltage: DC 24V

Applicable EMC Directive 2014/30/EU Standards: EN IEC 55015:2019+A11:2020

EN 61547:2009

EN IEC 61000-3-2:2019+A1:2021 EN 61000-3-3:2013+A1:2019

The above equipment has been tested by Precise Testing & Certification (Guangdong) Co., Ltd. and found compliance with the requirements in the technical standards mentioned above. The test results presented in this report only relate to the product/system tested. The Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Test Engineer:

Technical Manager:

Simon Pu/Manager

CatsonZhona

son Zhong / Engineer



2. TEST SUMMARY

EMISSION							
Standard Item Result Remarks							
0 0 0 0 0 0 0	Conducted (Main Port)	PASS	Complied with limit				
EN IEC 55015:2019+A11:2020	Radiated Electromagnetic Disturbance	PASS	Complied with limit				
	Radiated Emission	PASS	Complied with limit				
EN IEC 61000-3-2:2019+A1:2021	Harmonic current emissions	PASS	Complied with limit				
EN 61000-3-3:2013+A1:2019	Voltage fluctuations & flicker	PASS	Complied with limit				

IMMUNITY					
Standard	Item Result		Remarks		
IEC 61000-4-2:2008	ESD	PASS	Complied with the requirements		
IEC 61000-4-3:2006+ A1:2007	RS	PASS	Complied with the requirements		
IEC 61000-4-4:2004	EFT	N/A	O O N/A		
IEC 61000-4-5:2005	Surge	N/A	N/A		
IEC 61000-4-6:2008	CS	N/A	N/A		
EN 61000-4-8:1993+A1:2000	PFMF	N/A	O O N/A		
IEC 61000-4-11:2004	Voltage dips & voltage variations	N/A	N/A AC AC		

Note: 1) The test result verdict is decided by the limit of test standard

²⁾ The information of measurement uncertainty is available upon the customer's request.



3. TEST SITE

3.1. TEST FACILITY

Precise Testing & Certification (Guangdong) Co., Ltd.

Address: Building 1, No. 6, Tongxin Road, Dongcheng Street, Dongguan, Guangdong, China.

☆ CNAS Registration No.: CNAS L5772

☆ FCC Registration No.: 790290
 ☆ A2LA Certificate No.: 4408.01
 ☆ IC Registration No.: 12191A-1

3.2. MEASUREMENT UNCERTAINTY

Parameter 0 0 0 0 0 0	Uncertainty 0 0 0 0 0 0
Temperature	±1° C
Humidity	±5%
DC and Low Frequency Voltages	±3%
Conducted Emission(150KHz-30MHz)	±3.60dB
Radiated Emission(30MHz-1GHz)	±4.76dB
Radiated Emission (1GHz-18GHz)	±4.44dB

Note 1: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



3.3. LIST OF TEST AND MEASUREMENT INSTRUMENTS

3.3.1. For conducted emission at the mains terminals test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Aug 21, 2023
Artificial Mains Network	Rohde&Schwarz	ENV216	102453	Aug 21, 2023
ISN	SCHWARZBECK	NTFM8131	00257	Aug 21, 2023
Test S/W	Tonscend	Sic Sic Si	JS32-CE/4.0.0	.3

3.3.2. For radiated electromagnetic emission test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Aug 21, 2023
Triple-Loop Antenna	PATCH PANEL	RF300	9138	Aug 21, 2023
Test S/W	Tonscend	the sec sec	JS32-CE/4.0.0	0.3 60 60 6

3.3.3. For radiated emission test (30MHz-1GHz)

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EMI Test Receiver	Rohde&Schwarz	ESCI	101417	Aug 21, 2023
Bilog Antenna	SCHWARZBECK	VULB 9168	9168-3355	Aug 21, 2023
Preamplifier (low frequency)	SCHWARZBECK	BBV 9745	9745-0013	Aug 21, 2023
Test S/W	Tonscend	0 8/0 8/0 8	JS32-RE/4.0.0.	0 % % %

3.3.4. For harmonic current emissions and voltage fluctuations/flicker test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
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Harmonics / Flicker Test System	California Instruments	CTS/PACS-1-115	1534A00401	Aug 21, 2023
AC Power Source	California Instruments	3001IX-208-CTS	1534A00401	Aug 21, 2023
Test S/W	AMETEK	0 40 40 40	CTS 4	

3.3.5. For electrostatic discharge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
ESD Generator	SCHLODER	SESD216	606137	Aug 21, 2023

3.3.6. For radio frequency electromagnetic field immunity (R/S) test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Power meter	Agilent	E4419B	GB42421440	Aug 21, 2023
Isotropic Field Probe	Narda	EP-601	611WX80275	Aug 21, 2023
Amplifier	SKET	HAP_801000M-250W	201811050	Aug 21, 2023
Amplifier	SKET	HAP_0103G-75W	201811051	Aug 21, 2023
Amplifier	SKET	HAP_0306G-20W	201811052	Aug 21, 2023
Log-periodic Antenna	SKET	ZDSZ-80T1000M-231	SKT231015	Aug 21, 2023
Log-periodic Antenna	SKET	ZDSZ-1T6G-232	SKT232079	Aug 21, 2023

3.3.7. For electrical fast transient/burst immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
EFT Tester	HTEC	HV1P16T/HCOM PACT52	170901/190901	Aug 21, 2023
EFT Coupling Clamp	HTEC	HEFT 51-C	1416011	Aug 21, 2023



3.3.8. For surge immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due
Surge Tester	HTEC	HCWG 71	174302	Aug 21, 2023
Surge Tester	HTEC	TCOMB 4	142103	Aug 21, 2023
Surge Tester	HTEC	HTSG 70	175002	Aug 21, 2023

3.3.9. For injected currents susceptibility test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due	
C/S Test System	SCHLODER	CDG-6000-25	126A1279/2014	Aug 21, 2023	
Coupling Decoupling Network	SCHLODER	CDN-M2+3	A2210251/2013	Aug 21, 2023	
Electromagnetic Injection Clamp	Luthi	EM101 36041		Aug 21, 2023	
Test S/W	SCHLODER	\$ \$ \$ \$	CDG/1.0.0.0	8 8 8	

3.3.10. For power frequency magnetic field immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due	
Magnetic Field Tester	HTEC	HPFMF	142104	Aug 21, 2023	

3.3.11. For voltage dips and short interruptions immunity test

Name of Equipment	Manufacturer	Model	Serial No.	Calibration Due	
Dips Tester	HTEC	HV1P16T/HCOM PACT52	170901/190901	Aug 21, 2023	



4. EUT DESCRIPTION

Product	Switch on the power supply control module						
Model	RSRMEV2300-SC						
Supplied Voltage	24VDC 0.5A 1A						
Power	N/A						

I/O PORT

I/O PORT TYPES	Q'TY	TESTED WITH		
AC Port	\$0 \$0 \$0 \$0 \$0	40 40 \$0 \$0 \$0		
DC Port	20 20 10 20 20			

Models Difference

The power is inconsistent with the output current.



5. TEST METHODOLOGY

5.1. TEST MODE

The EUT was tested together with the thereinafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed.

	Test Items	Test Mode
	Conducted Emission	Lighting
	Radiated Electromagnetic Disturbance	Lighting
Emission	Radiated Emission	Lighting
	Harmonic current emissions	N/A
	Voltage fluctuations & flicker	N/A
	ESD	Lighting
	RS	Lighting
	EFT	N/A
Immunity	Surge	N/A
	C/S	N/A
	M/S	N/A
	Dips	N/A

5.2. EUT SYSTEM OPERATION

- 1. Set up EUT with the support equipment.
- 2. Make sure the EUT work normally during the test.



6. SETUP OF EQUIPMENT UNDER TEST

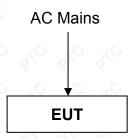
6.1. DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

No.	Equipment	Model	Serial No.	FCC ID	Trade Name	Data Cable	Power Cord
1.	N/A	N/A	N/A	N/A	N/A	N/A	N/A

Note: 1) All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.

6.2. CONFIGURATION OF SYSTEM UNDER TEST



(EUT: Switch on the power supply control module)

Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



7. EMISSION TEST

7.1. CONDUCTED EMISSION MEASUREMENT

7.1.1. LIMITS

FREQUENCY	LIMITS(dBμV)				
(MHz)	Quasi-peak	Average			
0.009-0.05	110	N/A			
0.05-0.15	90 – 80	N/A			
0.15 - 0.5	66 – 56	56 - 46			
0.50 - 5.0	56	46			
5.0 - 30.0	60	50			

Note: 1) The lower limit shall apply at the transition frequencies.

7.1.2. TEST PROCEDURES

The EUT and Support equipment, if needed, was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane, which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane. The EUT should be 0.8 m apart from the AMN, where the mains cable supplied by the manufacturer is longer than 0.8 m, the excess should be folded at the centre into a bundle no longer than 0.4 m, Details please refer to test setup photography.

The Receiver scanned from 9 kHz to 30 MHz for emissions in each of the test modes. During the above scans, the emissions were maximized by cable manipulation.

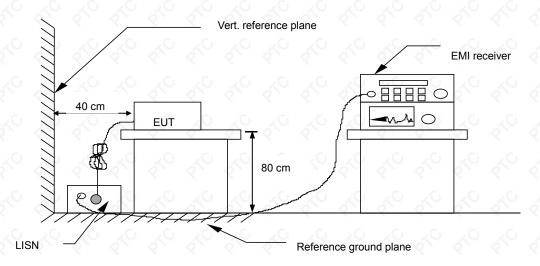
A scanning was taken on the power lines, Line and neutral, recording at least six highest emissions. Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: e3, Software Version: 1.0.0.0.

²⁾ The limit decreases in line with the logarithm of the frequency in the range of 0.15 MHz to 0.5 MHz



7.1.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.1.4. TEST RESULT

Product name	Switch on the power supply control module	Tested By	MING ZHI
Model	RSRMEV2300-SC	Detector Function	Peak / Quasi-peak/AV
Test Mode	Lighting	6 dB Bandwidth	200 Hz/9 kHz
Environmental Conditions	24.2℃, 55 % RH, 101.5 kPa	Test Result	Pass

Note:

L = Line Line, N = Neutral Line

Freq. = Emission frequency in MHz

Reading level ($dB\mu V$) = Receiver reading

Corr. Factor (dB) = attenuator + Cable loss

Level (dB μ V) = Reading level (dB μ V) + Corr. Factor (dB)

Limit ($dB\mu V$) = Limit stated in standard

Over Limit (dB) = Level (dB μ V) – Limit (dB μ V)

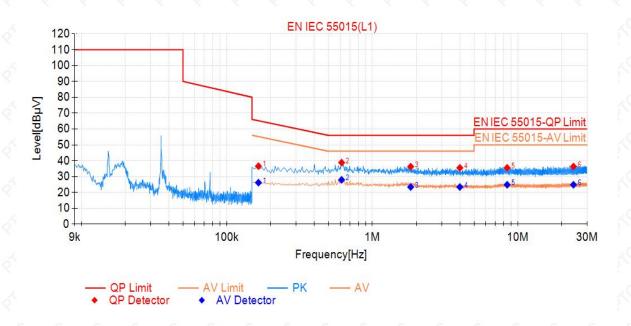
QP = Quasi-Peak

AV = Average



Please refer to the following diagram:

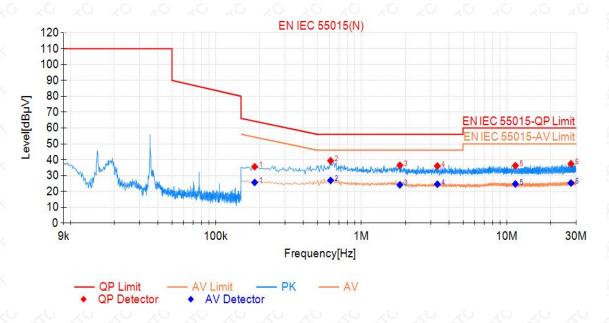
Line:



Final	Final Data List								
NO.	Freq. [MHz]	QP Value [dBµV]	QP Limit [dBµV]	QP Margin [dB]	AV Value [dBµV]	ΑV Limit [dBμV]	AV Margin [dB]	Verdict	
Q 1	0.165	36.57	65.21	28.64	26.17	55.21	29.04	PASS	
2	0.615	38.83	56.00	17.17	27.97	46.00	18.03	PASS	
3	1.835	36.27	56.00	19.73	23.43	46.00	22.57	PASS	
4	3.995	35.50	56.00	20.50	23.43	46.00	22.57	PASS	
5	8.445	35.51	60.00	24.49	24.86	50.00	25.14	PASS	
6	24.110	36.35	60.00	23.65	24.85	50.00	25.15	PASS	



Neutral:



Final	Final Data List							
NO.	Freq. [MHz]	QP Value [dBµV]	QP Limit [dBμV]	QP Margin [dB]	AV Value [dBµV]	AV Limit [dBµV]	AV Margin [dB]	Verdict
<u>(1)</u>	0.185	35.59	64.26	28.67	25.66	54.26	28.60	PASS
2	0.615	39.36	56.00	16.64	26.94	46.00	19.06	PASS
3	1.840	36.46	56.00	19.54	24.13	46.00	21.87	PASS
4	3.330	36.04	56.00	19.96	24.57	46.00	21.43	PASS
5	11.455	36.28	60.00	23.72	24.73	50.00	25.27	PASS
6	27.580	37.42	60.00	22.58	25.30	50.00	24.70	PASS



7.2. RADIATED ELECTROMAGNETIC DISTURBANCE

7.2.1. LIMITS

Francis man	Limits for loop diameter dB(μA)*				
Frequency	2 m	3 m	4 m		
9 kHz-70 kHz	88	81	75		
70 kHz-150 kHz	88-58**	81-51**	75-45**		
150 kHz-3.0 MHz	58-22**	51-15**	45-9**		
3.0 MHz-30 MHz	22	15-16***	9-12***		

^{*} At the transition frequency, the lower limit applies.

7.2.2. TEST PROCEDURE

The EUT and support equipment are positioned in the centre of loop antenna system (LAS). The LAS consists of three circular, mutually perpendicular large-loop antennas (LLAs), having a diameter of 2 m, supported by a non-metallic base. A 50 Ω coaxial cable between the current probe of an LLA and the coaxial switch, and between this switch and the measuring equipment, shall have surface transfer impedance smaller than 10 m Ω /m at 100 kHz and 1 m Ω /m at 10 MHz. The distance between the outer diameter of the loop antenna system and nearby objects, such as floor and walls, shall be at least 0.5 m as per CISPR 15/ EN 55015.

The induced current in the loop antenna is measured by means of a current probe (1 V/A) and the CISPR measuring receiver. By means of a coaxial switch, the three field directions (X, Y, Z) can be measured in sequence.

The receiver scanned from 9 kHz to 30 MHz for emissions in each of the test modes, and recorded at least the six highest emissions. Each value shall comply with the requirement given.

The test data of the worst-case condition(s) was recorded.

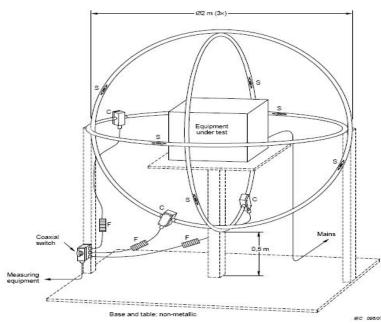
Note: Test Software Name: e3, Software Version: 1.0.0.0.

^{**} Decreasing linearly with the logarithm of the frequency.

^{***} Increasing linearly with the logarithm of the frequency.



7.2.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.2.4. TEST RESULT

Product name	Switch on the power supply control module	Antenna Pole	X, Y, Z
Model	RSRMEV2300-SC	300-SC Antenna Diameter	
Test Mode	Lighting	Detector Function	Peak
Environmental Conditions	24.2℃, 55 % RH, 101.5 kPa	6 dB Bandwidth	200 Hz/9 kHz
Tested By MING ZHI		Test Result	Pass

Note:

Freq. = Emission frequency in MHz

Reading level $(dB\mu A)$ = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss

Measurement ($dB\mu A$) = Reading level ($dB\mu A$) + Corr. Factor (dB)

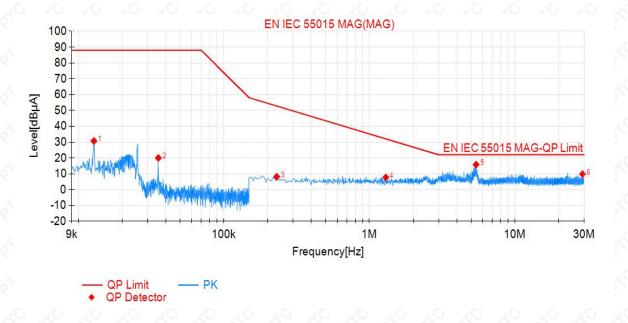
Limit ($dB\mu A$) = Limit stated in standard

Over Limit (dB) = Measurement (dB μ A) – Limit (dB μ A) QP = Quasi-Peak



Please refer to the following diagram:

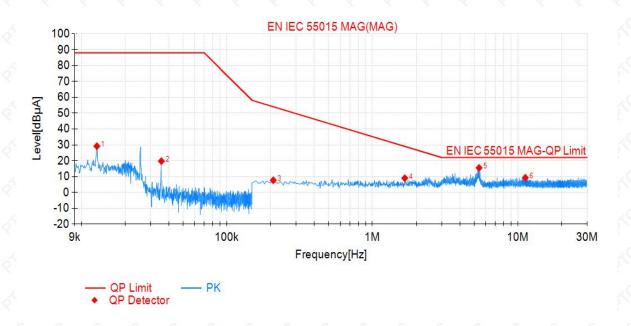
X:



Final D	Final Data List						
NO.	Freq. [MHz]	QP Value [dBµA]	QP Limit [dΒμΑ]	QP Margin [dB]	Verdict		
Q 1 Q	0.013	30.75	88.00	57.25	PASS		
2	0.036	20.03	88.00	67.97	PASS		
3	0.231	8.16	52.81	44.65	PASS		
4	1.298	7.72	32.07	24.35	PASS		
5	5.415	15.81	22.00	6.19	PASS		
6	29.238	9.82	22.00	12.18	PASS		



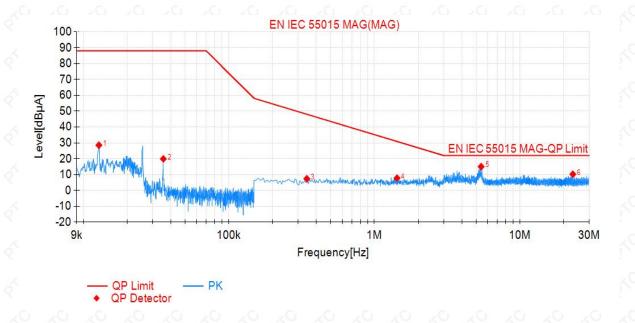




Final Da	Final Data List						
NO.	Freq. [MHz]	QP Value [dВµА]	QP Limit [dBμΑ]	QP Margin [dB]	Verdict		
2 1 2	0.013	29.20	88.00	58.80	PASS		
2	0.036	19.74	88.00	68.26	PASS		
3	0.209	7.68	54.04	46.36	PASS		
4	1.671	9.02	29.03	20.01	PASS		
5	5.415	15.51	22.00	6.49	PASS		
6	11.252	9.25	22.00	12.75	PASS		



Z:



Final D	Final Data List							
NO.	Freq. [MHz]	QP Value [dΒμΑ]	QP Limit [dBμΑ]	QP Margin [dB]	Verdict			
20 2	0.013	28.55	88.00	59.45	PASS			
2	0.036	19.90	88.00	68.10	PASS			
3	0.344	7.38	48.04	40.66	PASS			
4	1.433	7.77	30.88	23.11	PASS			
5	5.420	15.01	22.00	6.99	PASS			
6	23.132	10.23	22.00	11.77	PASS			



7.3. RADIATED EMISSION MEASUREMENT

7.3.1. LIMITS

FREQUENCY (MHz)	Limit (dBμV/m) (At 3 m)	Limit (dBµV/m) (At 10 m)
30 ~ 230	40	30
230 ~ 1000	47	37

Note: 1) The lower limit shall apply at the transition frequencies.

2) Emission level (dB μ V/m) = 20 log Emission level (μ V/m).

7.3.2. TEST PROCEDURE

The equipment was set up as per the test configuration to simulate typical usage per the user's manual. When the EUT is a tabletop system, a wooden turntable with a height of 0.8 meters is used which is placed on the ground plane. When the EUT is floor standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.

The antenna was placed at 3 meter away from the EUT. The antenna connected to the spectrum analyzer via a cable and at times a pre-amplifier would be used.

The analyzer / receiver quickly scanned from 30 MHz to 300 MHz. The EUT test program was started. Emissions were scanned and measured rotating the EUT to 360 degrees and positioning the antenna 1 to 4 meters above the ground plane, in both the vertical and the horizontal polarization, to maximize the emission reading level.

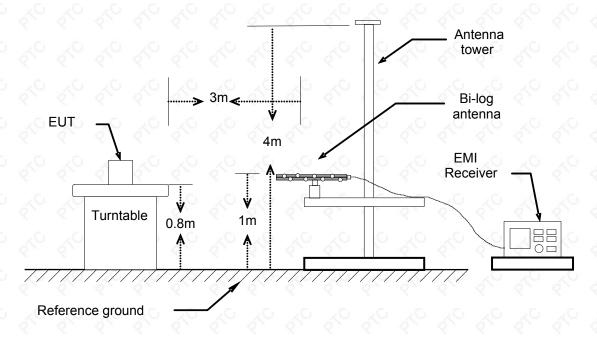
During the above scans, the emissions were maximized by cable manipulation. Each modes is measured, recorded at least the six highest emissions. Emission frequency, amplitude, antenna position, polarization and turntable position were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit and only Q.P. reading is presented.

The test data of the worst-case condition(s) was recorded.

Note: Test Software Name: e3, Software Version: 8.2.1.0.



7.3.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration

7.3.4. TEST RESULT

Product name	Switch on the power supply control module	Antenna Distance	3 m	
Model	RSRMEV2300-SC	Antenna Pole	Vertical / Horizontal	
Test Mode	Lighting	Detector Function	Peak / Quasi-peak	
Environmental Conditions	24.5℃, 52 % RH, 101.3 kPa	6 dB Bandwidth	120 kHz	
Tested by	S S Lu S S S	Test Result	Pass	

Note:

Freq. = Emission frequency in MHz

Reading level ($dB\mu V$) = Receiver reading($dB\mu V$)

Corr.Factor (dB/m)=Antenna factor(dB/m)+Cable loss(dB)-Preamp Factor(dB)

Measurement ($dB\mu V/m$)=Reading level($dB\mu V$)+ Corr. Factor (dB/m)

Limit ($dB\mu V/m$) = Limit stated in standard

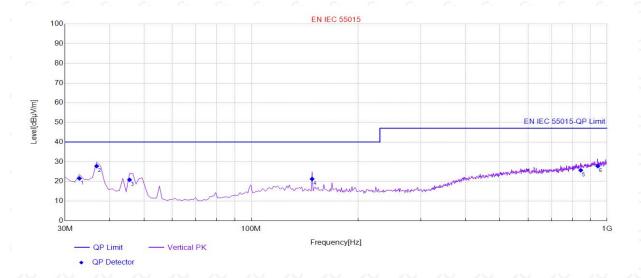
Over Limit (dB) = Measurement (dB μ V/m) – Limit (dB μ V/m)

QP = Quasi-Peak



Please refer to the following diagram:

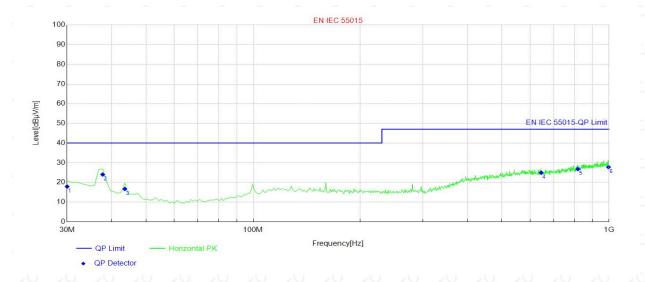
Vertical:



Final	Final Data List[QP]							
NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB/m]	QP Value [dBµV/m]	QP Limit [dBµV/m]	QP Margin [dB]	Polarity	Verdict
1	32.91	36.69	-15.18	21.51	40.00	18.49	Vertical	PASS
2	36.79	44.84	-17.06	27.78	40.00	12.22	Vertical	PASS
3	45.52	41.68	-20.88	20.80	40.00	19.20	Vertical	PASS
4	148.34	40.00	-18.77	21.23	40.00	18.77	Vertical	PASS
5	843.83	32.12	-6.46	25.66	47.00	21.34	Vertical	PASS
6	942.77	33.60	-5.84	27.76	47.00	19.24	Vertical	PASS



Horizontal:



Final	Final Data List[QP]							
NO.	Freq. [MHz]	QP Reading [dBμV]	Factor [dB/m]	QP Value [dBµV/m]	QP Limit [dBµV/m]	QP Margin [dB]	Polarity	Verdict
1	30.00	31.62	-13.76	17.86	40.00	22.14	Horizontal	PASS
2	37.76	41.53	-17.53	24.00	40.00	16.00	Horizontal	PASS
3	43.58	36.74	-20.09	16.65	40.00	23.35	Horizontal	PASS
4	644.98	34.12	-9.23	24.89	47.00	22.11	Horizontal	PASS
5	817.64	33.51	-6.73	26.78	47.00	20.22	Horizontal	PASS
6	997.09	33.04	-5.28	27.76	47.00	19.24	Horizontal	PASS



7.4. HARMONICS CURRENT MEASUREMENT

7.4.1. LIMITS OF HARMONICS CURRENT MEASUREMENT

Limit for C	lass A equipment
Harmonics	Max. permissible
Order N	harmonics current A
Odd	harmonics
3	2.30
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
15≦n≦39	0.15x(15/n)
Eve	n harmonics
2	1.08
4	0.43
, G 6 , G	0.30
8≦n≦40	0.23x8/n

	Limit for Class D equip	oment
Harmonics Order n	Max. permissible harmonics current per watt mA/W	Max. permissible harmonics current A
	Odd Harmonics on	ly 6 6 6
3	3.4	2.30
5	1.9	1.14
7.0.	1.0	0.77
9	0.5	0.40
11.	0.35	0.33
13	0.30	0.21
15≦n≦39 (odd harmonics only)	3.85/n	0.15x(15/n)
KC &C &	40 40 40 40	40 40 40 40
KO KO K	36 60 60 60	10 10 10 10

Limit for Class C equipment ^a					
Harmonics Order n	Max. permissible harmonics current expressed as a percentage of the input current at the fundamental frequency A				
2	2				
8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8 8	27 ^b				
5	10				
50 50 50 50 50 50 50	10 80 80 80 80 8 7 80 80 80 80 80				
9	5				
11≦n<≦39 (odd harmonics only)	3 4 4 4 4 4				

^a:For some Class C products, other emission limits apply (see EN IEC 61000-3-2 7.4).

Note: Class A, B, C and D are classified according to item 7.4.2.of this report

b:The limit is determined based on the assumption of modern lighting technologies having power factors of 0,90 or higher



7.4.2. TEST PROCEDURES

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic. The classification of EUT is according to section 5 of EN IEC 61000-3-2.

The EUT is classified as follows:

Class A:

Equipment not specified as belonging to Class B, C or D shall be considered as Class A equipment.

Some examples of Class A equipment are:

- balanced three-phase equipment;
- household appliances, excluding those specified as belonging to Class B, C or D;
- vacuum cleaners;
- high pressure cleaners;
- tools, excluding portable tools;
- independent phase control dimmers;
- audio equipment;
- professional luminaires for stage lighting and studios.

NOTE 1 Equipment that can be shown to have a significant effect on the supply system might be reclassified in a future edition of this document, taking into account the following factors:

- number of pieces of equipment in use;
- duration of use;
- simultaneity of use;
- power consumption;
- harmonic spectrum, including phase.

Class B:

- portable tools;
- arc welding equipment which is not professional equipment.

Class C:

lighting equipment.

Class D:

Equipment having a specified power less than or equal to 600 W according to 6.3.2, of the following types:

personal computers and personal computer monitors;

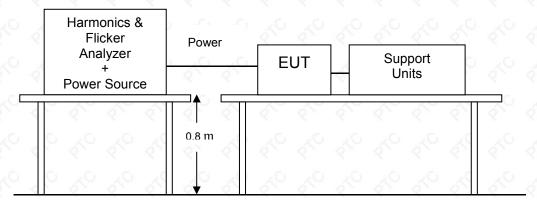


- television receivers;
- refrigerators and freezers having one or more variable-speed drives to control compressor motor(s).

NOTE 2 Class D limits are reserved for equipment that, by virtue of the factors listed in note 1, can be shown to have a pronounced effect on the public electricity supply system.

The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the time necessary for the EUT to be exercised.

7.4.3. TEST SETUP



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.4.4. TEST RESULT

N/A

Please refer to the following test data: N/A



7.5. VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

7.5.1. LIMITS OF VOLTAGE FLUCTUATION AND FLICKS MEASUREMENT

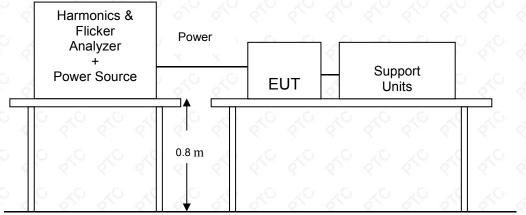
TEST ITEM LIMIT		REMARK	
P _{st}	1.0	P _{st} means short-term flicker indicator.	
? ?P _{It} ?	0.65	P _{It} means long-term flicker indicator.	
T _{dt} (ms)	500	T _{dt} means maximum time that dt exceeds 3 %.	
d _{max} (%)	4/6/7 %	d _{max} means maximum relative voltage change.	
dc (%)	3.3 %	dc means relative steady-state voltage change	

7.5.2. TEST PROCEDURE

The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under lighting operating conditions. During the flick measurement, the measure time shall include that part of whole operation cycle in which the EUT produce the most unfavorable sequence of voltage changes. The observation period for short-term

flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

7.5.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

7.5.4. TEST RESULT

N/A



8. IMMUNITY TEST

8.1. GENERAL DESCRIPTION

Product	EN 61547						
Standard	Test Type	Minimum Requirement					
	IEC 61000-4-2	Electrostatic Discharge – ESD: ±8 kV air discharge, ±4 kV Contact discharge, Performance Criterion B					
	IEC 61000-4-3	Radio-Frequency Electromagnetic Field Susceptibility Test – RS: 80 ~1000 MHz, 3 V/m, 80 % AM(1 kHz), Performance Criterion A					
	IEC 61000-4-4	Electrical Fast Transient/Burst - EFT, Power line: ±1 kV, Signal line: ±0.5 kV, Performance Criterion B					
Basic Standard, Specification, and Performance Criterion required	IEC 61000-4-5	Surge Immunity Test: 1.2/50 μs Open Circuit Voltage, 8 /20 μs Short Circuit Current, Power Port ~ Line to line: ±0.5 kV, Line to ground: ±1 kV (to self-ballasted lamps and semi-luminaries; luminaires a independent auxiliaries which are less than or equal to 25 Power Port ~ Line to line: ±1 kV, Line to ground: ±2 kV (to luminaires and independent auxiliaries which are more to 25 W) Signal Port: ±0.5 kV Performance Criterion B					
	IEC 61000-4-6	Conducted Radio Frequency Disturbances Test –CS: 0.15 ~ 80 MHz, 3 Vrms, 80 % AM, 1 kHz, Performance Criterion A					
	IEC 61000-4-8	Power frequency magnetic field immunity test 50 Hz, 3 A/m Performance Criterion A					
	IEC 61000-4-11	Voltage Dips and Interruptions: i) 70 % reduction for 10 period, Performance Criterion C ii) 0 % reduction for 0.5 period Performance Criterion B					



8.2. GENERAL PERFORMANCE CRITERIA DESCRIPTION

Criteria A:	During the test no change of the luminous intensity shall be observed and the regulating control, if any, shall operate during the test as intended.	
Criteria B:	During the test the luminous intensity may change to any value. After the test the luminous intensity shall be restored to its initial value within 1 min.	
	Regulating controls need not function during the test, but after the test the mode of the control shall be the same as before the test provided that during the test no mode changing commands were given.	
Criteria C:	During and after the test any change of the luminous intensity is allowed and the lamp(s) may be extinguished. After the test, within 30 min, all functions shall return to normal. if necessary by temporary interruption the mains supply and/or operating the regulating control.	
	Additional requirement for lighting equipment incorporating a starting device:	
	After the test the lighting equipment is switched off. After half an hour it is switched on again. The lighting equipment shall start and operate as intended.	



8.3. ELECTROSTATIC DISCHARGE (ESD)

8.3.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-2

Discharge Impedance: 330 Ω **Charging Capacity:** 150 pF

Discharge Voltage: Air Discharge: ±8 kV (Direct)

Contact Discharge: ±4 kV (Direct/Indirect)

Polarity: Positive & Negative

Number of Discharge: 10 times at each test point

Discharge Mode: 1 time/s

Performance Criterion:

8.3.2. TEST PROCEDURE

The discharges shall be applied in two ways:

- a) Contact discharges to the conductive surfaces and coupling planes:
 Twenty dischargers (10 with positive and 10 with negative polarity) shall be applied on each accessible metallic part of the enclosure, terminals are excluded. In case of a non-conductive enclosure, dischargers shall be applied on the horizontal or vertical coupling planes. Test shall be performed at a maximum repetition rate of one discharge per second.
- b) Air discharges at slots and apertures and insulating surfaces:
 On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled by the user. A minimum of 10 single air

The basic test procedure was in accordance with IEC 61000-4-2:

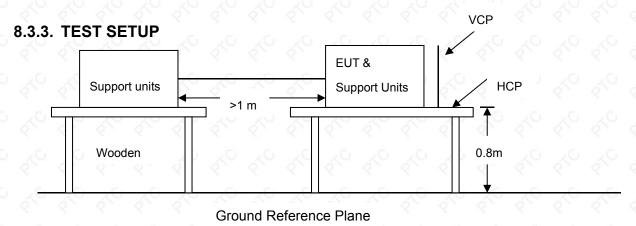
discharges shall be applied to the selected test point for each such area.

- a) The EUT was located 0.1 m minimum from all side of the HCP (dimensions 1.6 m \times 0.8 m).
- b) The support units were located another table 30 cm away from the EUT, but direct support unit was/were located at same location as EUT on the HCP and keep at a distance of 10cm with EUT.
- c) The time interval between two successive single discharges was at least 1 second.
- d) Contact discharges were applied to the non-insulating coating, with the pointed tip of



the generator penetrating the coating and contacting the conducting substrate.

- e) Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were complete.
- f) At least ten single discharges (in the most sensitive polarity) were applied at the front edge of each HCP opposite the center point of each unit of the EUT and 0.1 meters from the front of the EUT. The long axis of the discharge electrode was in the plane of the HCP and perpendicular to its front edge during the discharge.
- g) At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane (VCP) in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5 m x 0.5 m) was placed vertically to and 0.1 meters from the EUT.



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

Note:

1) TABLE-TOP EQUIPMENT

The configuration consisted of a wooden table 0.8 meters high standing on the ground reference plane (GRP) . The GRP consisted of a sheet of aluminum at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system. A horizontal coupling plane (HCP) (1.6 m x 0.8 m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test, was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5 mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

2) FLOOR-STANDING EQUIPMENT



The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the ground reference plane by an insulating support of 0.1 meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

8.3.4. TEST RESULT

Product	Switch on the power supply control module	Environmental Conditions	22.1℃, 52 % RH, 101.2 kPa
Model	Model RSRMEV2300-SC		Bruce
Test mode	Test mode Lighting		Pass

Air Discharge						
Test Levels Results						
Test Points	± 8 kV	Pass	Fail	Observation	Performance Criterion	
Hull 1 Points		\boxtimes		Note ⊠ A □ B □ C	В	
Gap 6 Points		\boxtimes		Note ⊠ A □ B □ C	В	

Contact Discharge						
	Test Levels	Results				
Test Points	± 4 kV	Pass	Fail	Observation	Performance Criterion	
HCP 4 Points	\boxtimes	\boxtimes		Note ⊠ A □ B □ C	В	
VCP 4 Points	\boxtimes	\boxtimes		Note ⊠ A □ B □ C	В	

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change, and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.4. RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD (RS)

8.4.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-3

Frequency Range: 80 MHz ~ 1000 MHz

Field Strength: 3 V/m

Modulation: 1 kHz Sine Wave, 80 %, AM Modulation

Frequency Step: 1 % of preceding frequency value

Polarity of Antenna: Horizontal and Vertical

Test Distance: 3 m
Antenna Height: 1.5 m
Performance Criterion: A

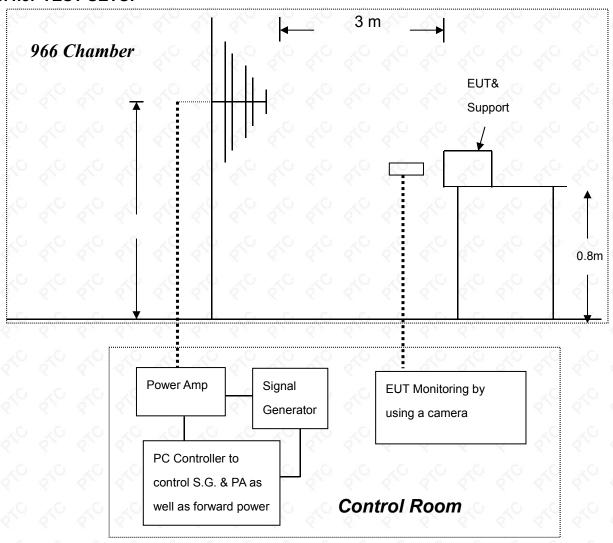
8.4.2. TEST PROCEDURE

The test procedure was in accordance with IEC 61000-4-3

- a) The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b) The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1 kHz sine-wave. The rate of sweep did not exceed 1.5 x 10 ⁻³ decade/s, where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value.
- c) The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d) The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



8.4.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration. Note:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



8.4.4. TEST RESULT

Product	Switch on the power supply control module	Environmental Conditions	24.1℃, 53 % RH, 101.1 kPa
Model	RSRMEV2300-SC	Tested By	Bruce
Test mode	Lighting	Test Result	Pass

Frequency (MHz)	Polarity	Position	Field Strength (V/m)	Observation	Performance Criterion
80 ~ 1000	V&H	Front	30	Note ⊠ A □ B □ C	CASO S
80 ~ 1000	V&H	Rear	3	Note ⊠ A □ B □ C	o ZA
80 ~ 1000	V&H	Left	3	Note ⊠ A □ B □ C	A
80 ~ 1000	V&H	Right	3	Note ⊠A □ B □ C	A A

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



8.5. ELECTRICAL FAST TRANSIENT (EFT)

8.5.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-4

Power Line: ±1 kV

Signal/Control Line: ±0.5 kV

Polarity: Positive & Negative

Impulse Frequency:5 kHzImpulse Wave-shape:5/50 nsBurst Duration:15 msBurst Period:300 msTest Duration:2 mins

Performance Criterion: B

8.5.2. TEST PROCEDURE

EUT is placed on a 0.1 m tall wooden table.

EUT operate at normal mode, the transient/burst was 5/50 ns in accordance with IEC 61000-4-4, both positive and negative polarity burst waveform were applied.

The duration time of each test line was 2 minutes.

8.5.3. TEST SETUP

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4.

For the actual test configuration, please refer to the related item – photographs of the test configuration.



8.5.4. TEST RESULT

Product	Switch on the power supply control module	Environmental Conditions	24.3℃, 54 % RH, 101.2 kPa
Model	RSRMEV2300-SC	Tested By	Bruce
Test mode	Lighting	Test Result	Pass

Test Point	Polarity	Test Level (kV)	Observation	Performance Criterion
	+/-	. 1.	Note ⊠ A ☐ B ☐ C	В
S SN S	+/-	8 18 8	Note ⊠ A □ B □ C	В
√° L'=N√° ⟨	+/-	15° 5°	Note ⊠A ☐ B ☐ C	B A
O PE	O +/-	_X 0 1 _X 0 _X	Note ⊠A ☐ B ☐ C	, B , o
L – PE	+/-	1, 1	Note ⊠ A □ B □ C	В
N – PE	+/-	₹ 18 €	Note ⊠A ☐ B ☐ C	₹ ₹B
L-N-PE	(° +/-	50 150 S	Note ⊠ A ☐ B ☐ C	S B
Signal/Control cable	e se se	80 -80 8	5 %0 % 5 %0 %0	10 10 10

Note: A) There was no change compared with initial operation during the test.

B) During the test the luminous intensity change ,and after the test the luminous intensity can be restored to its initial value within 1 min.

C) During the test, the luminous intensity change and after the test the luminous intensity can return to normal within 30 min.



Test Voltage:

8.6. SURGE IMMUNITY TEST

8.6.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-5

Combination Wave

Wave-Shape: 1.2/50 μs Open Circuit Voltage

8/20 μs Short Circuit Current

Power Port ~ Line to line: ±0.5 kV,

Line to ground: ±1 kV

(to self-ballasted lamps and semi-luminaries;

luminaires and independent auxiliaries which are less

than 25 W)

Power Port ~ Line to line: ±1 kV, Line to ground: ±2 kV (to luminaires and independent auxiliaries which are

more than 25 W)

Surge Input/Output: Power Line: L-N / L-PE / N-PE

Generator Source Impedance: 2Ω between networks

12 Ω between network and ground

Polarity: Positive/Negative

Phase Angle: 90°(positive polarity pulses) / 270°(negative polarity

pulses)

Pulse Repetition Rate: 1 time / min.

Number of Tests: 5 positive polarity pulses at the 90° phase angle, and 5

negative polarity pulses at 270° phase angle

Performance Criterion: B

8.6.2. TEST PROCEDURE

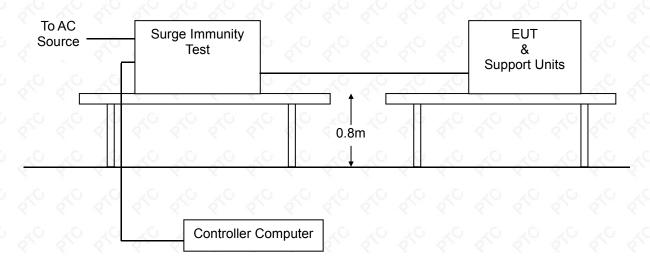
EUT is placed on a 0.1 m (table type equipment) / 0.8 m (floor type equipment) tall wooden table.

EUT operate at normal mode, two types of combination wave generator (1.2/50 us open-circuit voltage and 8/20 us short-circuit current) are applied to the EUT power supply terminals via the capacitive coupling network.

The power cord between the EUT and the coupling/decoupling network shall not exceed 2 m in length.



8.6.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

8.6.4. TEST RESULT

N/A



8.7. CONDUCTED RADIO FREQUENCY DISTURBANCES (CS)

8.7.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-6

Frequency Range: 0.15 MHz ~80 MHz

Field Strength: 3 V

Modulation: 1 kHz Sine Wave, 80 %, AM Modulation

Frequency Step: 1 % of preceding frequency value

Coupled cable: Power Mains, Shielded

Coupling device: CDN-M3/2 (3 wires/2 wires)

Performance Criterion: A

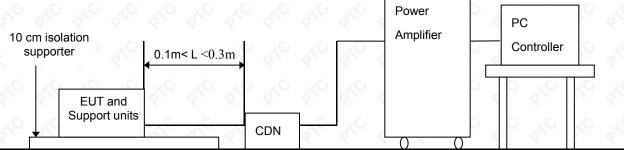
8.7.2. TEST PROCEDURE

The EUT shall be tested within its intended operating and climatic conditions.

The test shall performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50 Ω load resistor.

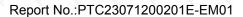
The frequency range was swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80 % amplitude. The signal was modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate was 1.5×10^{-3} decades/s. Where the frequency range is swept incrementally, the step size was 1 % of preceding frequency value the dwell time of the amplitude modulated carrier at each frequency was 0.5×10^{-3} decades.





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration Note: 1) The EUT is setup 0.1 m above Ground Reference Plane

2) All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.





8.7.4. TEST RESULT

N/A



8.8. POWER FREQUENCY MAGNETIC FIELD

8.8.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-8

Frequency Range: 50 Hz Field Strength: 1A/m

Observation Time: 5 minutes

Inductance Coil: Rectangular type, 1 m x 1 m

Performance Criterion: A

8.8.2. TEST PROCEDURE

The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1 m-thick insulating support.

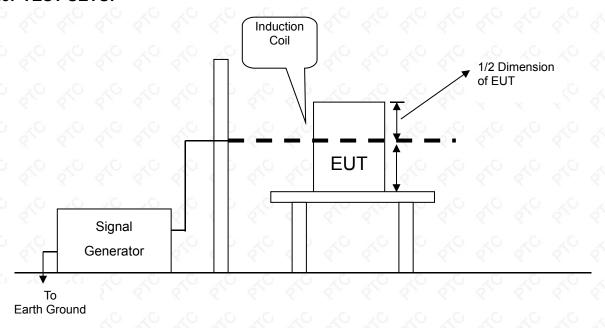
The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.

The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.

The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.



8.8.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration Note:

TABLETOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

8.8.4. TEST RESULT

The test only applies to apparatus containing device susceptible to magnetic fields, such as hall elements or magnetic field sensor, so this item isn't applicable to the products.



8.9. VOLTAGE DIP & VOLTAGE INTERRUPTIONS

8.9.1. TEST SPECIFICATION

Basic Standard: IEC 61000-4-11

Test Duration Time: 3 test events in sequence

Interval Between Event: 10 seconds

Phase Angle: 0°

Test Cycle: 3 times

Performance Criterion: $0\% U_T / 0.5 P$, Criterion: B

70% *U*_T / 10 P, Criterion: C

8.9.2. TEST PROCEDURE

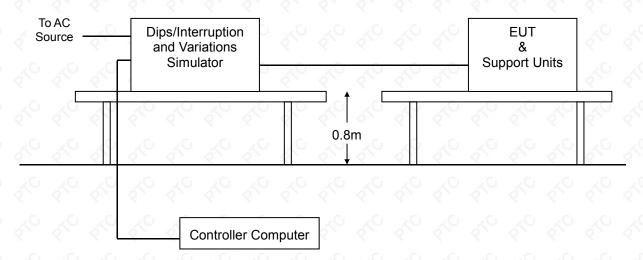
The EUT and support units were located on a wooden table, 0.8 m away from ground floor.

Setting the parameter of tests and then perform the test software of test simulator.

Changes to the voltage level shall occur at 0 degree crossing point in the a.c. voltage waveform.

Record the test result in test record form.

8.9.3. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.





8.9.4. TEST RESULT

N/A



9. PHOTOGRAPHS OF THE TEST CONFIGURATION CONDUCTED EMISSION TEST

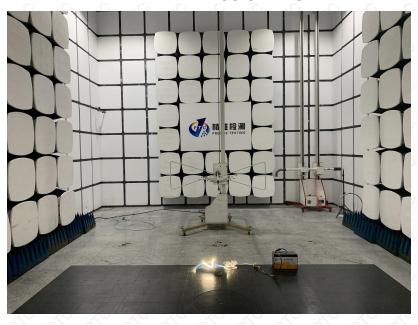


RADIATED ELECTROMAGNETIC EMISSION TEST

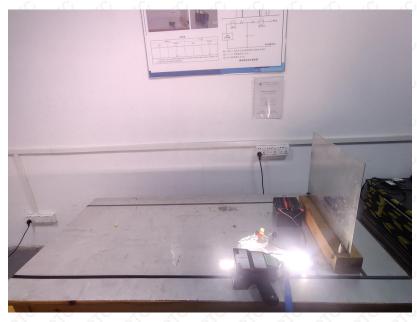




RADIATED EMISSION TEST

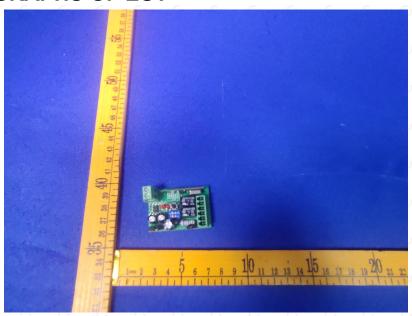


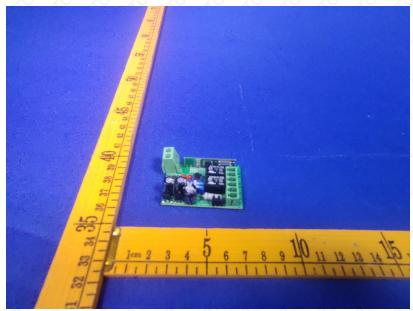
ESD TEST



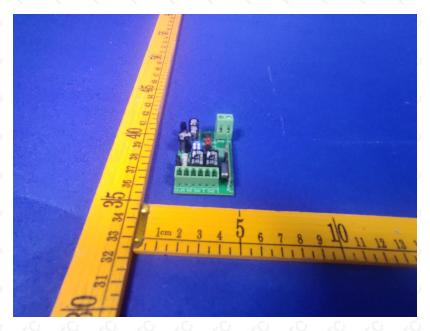


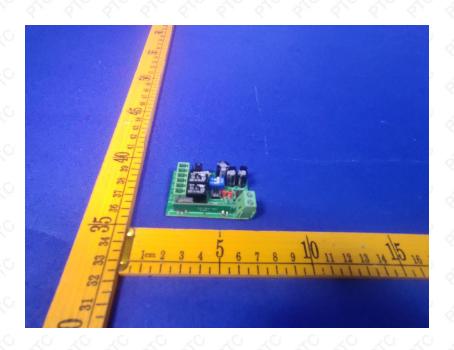
10. PHOTOGRAPHS OF EUT



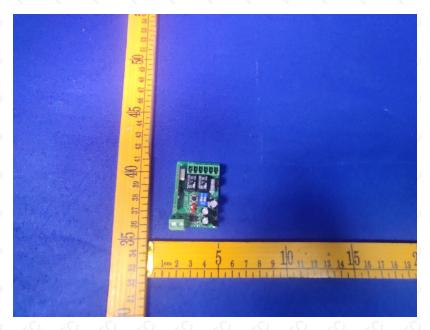


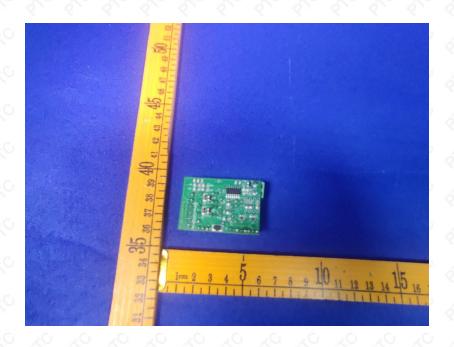












— End of report —

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